## **Electronic Supplementary Information**

# **Chalcogen Alloying Mediated Electronic Structure Modulation in Nb(SxSe(1-x))2 Nanosheets for Hydrogen Evolution Reaction**

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Fig. S1 (a) color of precursor solution containing  $(PhCH_2)_2Se_2/(PhCH_2)_2S_2$ , NbCl<sub>5</sub> and oleyl amine (OLAM); (b) dropwise injection of precursor solution into pre-heated OLAM solution kept at 300 °C; (c) color change to black upon precursor injection.



**Fig.** S2 AFM images: (a) NbSe<sub>2;</sub> (b) NbS<sub>2</sub> nanosheets. For NbSe<sub>2</sub>, height profile is 1.8 nm, confirming 2 layers thickness. Whereas for  $NbS<sub>2</sub>$  it is 1.2 nm which confirms approximately 1 layer thickness, considering the presence of OLAM ligand  $(0.5 \text{ nm})^1$ . This confirms the transformation from monolayer to bilayer thickness, along c-axis with increasing Se content.



**Fig. S3** Raman spectra of  $Nb(S_xSe_{(1-x)})_2$  NSs under 532nm laser.

To comprehend the structure of  $Nb(S_xSe_{(1-x)})_2$ , Raman spectra were collected under a 532 nm laser. It displays two vibration modes with Nb-Se modes at a lower frequency than Nb-S modes. The spectrum for NbSe<sub>2</sub> shows contribution from two peaks, i.e., in-plane  $E_{2g}$  mode (245 cm<sup>-1</sup>) and out-of-plane  $A_{1g}$  mode (225 cm<sup>-1</sup>) vibrations.<sup>2</sup> With initial x = 0.25 doping of S, there is slight shift towards the higher wavenumber observed due the softening of Nb-Se modes. For x=0.25, 0.5 and 0.75 there is dominance of Nb-Se modes compared to Nb-S modes which is indicative of relatively higher Se concentration in  $Nb(S_xSe_{(1-x)})_2$ .<sup>3</sup> Complete substitution of Se with S in NbS<sub>2</sub> features peaks at 307 cm<sup>-1</sup> and 355 cm<sup>-1</sup> assignable to  $E_{2g}$  and  $A_{1g}$  modes, respectively.<sup>4</sup>









**x = 0.75 NbS2/3Se1/2**





**Fig. S4** FE-SEM based corresponding elemental distribution maps and spectrum showing uniform distribution of Nb, Se and S of  $x = 0$ ; 0.25;  $x = 0.75$ ;  $x = 1$ . The FE-SEM image shows sheet type surface morphology. EDX spectrum exhibits relatively high atomic percentage of Se w.r.t. S.



**Table S1** S:Se ratios of loaded composition and FE-SEM EDX elemental mapping for all compositions highlighting the actual S content is lesser compared to the nominal amounts. To explain this observation, we propose the reason to be difference in rate of decomposition of the chalcogen precursors with C-S bond being relatively stronger than C-Se bond (Bond dissociation energy: C-S: 699 KJ/mol and C-Se: 582 KJ/mol $)^5$  and hence lesser S goes into the lattice than feed in amounts.



**Fig. S5** high resolution XPS spectra of (a) Se - 3d spectra shows two peaks at 53.01 and 54.94 eV corresponding to  $3d_{5/2}$  and  $3d_{3/2}$  binding energies.<sup>6,7</sup> The 3d spectra of Se can be deconvoluted into two doublets possibly due to presence of Se intermediates left over from the decomposition of (PhCH<sub>2</sub>)<sub>2</sub>Se<sub>2</sub>.<sup>8</sup> Also, there is peak due to SeO<sub>x</sub> in all compositions; (b) S-2p spectra.



**Fig. S6** (a,b) band plots of bilayer NbSe<sub>2</sub> and monolayer NbS<sub>2</sub>; (c,d) DOS plots of  $x=0.25$ ,  $x=0.75$  for  $Nb(S_xSe_{(1-x)})$  showing variation in d band contribution at fermi level with chalcogen variation.



Fig. S7 (a,b) TGA curves of NbSe<sub>2</sub> and NbS<sub>2</sub> nanosheets (NSs) respectively showing approximately 30% loss in the molecular weight at 368°C corresponding to loss due to surface OLAM ligand. Surface ligands were removed to enhance the conductivity; (c,d) FTIR spectra of NbSe<sub>2</sub> and NbS<sub>2</sub> NSs respectively, before and after annealing at 500°C. All other compositions were also annealed at 500°C for electrochemical studies.



**Fig.** S8 (a) For  $x = 0.5$  (NbSSe), chronoamperometry response at different potentials referenced w.r.t. RHE; (b) corresponding linear fit of steady state current density at 90<sup>th</sup> second gives the tafel slope of  $121 \text{mV/dec}$  for  $x = 0.5$  composition; (c) LSV curves with current density normalized w.r.t ECSA showing high intrinsic conductivity of  $x = 0.5$  composition.



**Fig.** S9 (a-e) Cyclic voltametric curves of  $Nb(S_xSe_{(1-x)})_2$  for  $x = 0$ , 0.25, 0.5, 0.75, 1. CV for all compositions of 2D Nb( $S_xSe_{(1-x)}$ )<sub>2</sub> NSs were collected in the non-faradaic potential window i.e.,  $0 - 0.2V$ vs RHE at scan rates 5 mV /s,  $10$  mV /s,  $20$  mV/s,  $40$  mV/s and  $60$  mV/s.

#### **ECSA calculations:**

Cyclic voltammetry curves were collected in the non-faradaic region. Half of the difference in the anodic and cathodic current densities at the intermediate value of CV curves (i.e. 0.1 V) was plotted as a function of scan rate. Linear fitting of the graph gives double layer capacitance (Cdl). Cdl values are a direct measure of the electrochemical surface area.<sup>9,10</sup>

$$
ECSA = \frac{C_{dl}}{C_s}
$$

 $C_s$  is the specific capacitance, the value of which is 40  $\mu F \, cm^{-2}$  per  $cm_{ECSA}^2$ 

### **Electrochemical Impedance fitting parameters:**





**Table S2** fitting parameter values of the Nyquist plot obtained via Electrochemical Impedance Spectroscopy.  $Rs:$  Solution resistance;  $R1, R2:$  Electrolyte and charge transfer resistance;  $CPE$ : Constant phase element



**Table S3** Comparison of HER activity of Nb based dichalcogenide electrocatalysts in 0.5M H2SO4.

## **Vacancy formation energy:**

To calculate the defect formation energy  $(E_f)$  of the S/Se vacancy, the following expression was used:

$$
E_f(vac) = E(vac) - E(pristine) - \mu(Sor Se)
$$

where  $E(Vac)$  is the total energy of system with an S or Se vacancy,  $E(pristine)$  is the total energy of the system without any defects, and S/Se is the chemical potential of S or Se.

# $x=0.5$  (NbSSe)  $a)$ b) H-adsorption on S vacancy  $(V_s)$ H-adsorption on Se-top H-adsorption on Se-top close to S atom in between layers  $\Delta G_{H^*} = 0.296 \text{eV}$  $\Delta G_{H*} = 0.08$  eV  $\Delta G_{H^*} = 0.37$ eV

Fig. S10 (a,b) chemical structure of reaction intermediates for H adsorbed on Se<sub>top</sub> and Se<sub>top</sub> near S for defect free model in x=0.5 (NbSeS) composition respectively. Lower Gibbs free energy  $(\Delta G_{H*})$  value reflects role of polarized electric field in alloy sample due to crystal distortion leading to easy desorption process; (c) reaction intermediate depicting H adsorption on sulphur vacancy  $(V_s)$  in between layers.

### **Gibbs Free Energy Calculations:**

By using an equation, we were able to estimate the Gibbs free energy of atomic hydrogen adsorption.

$$
\Delta G_H = \Delta E_H + ZPE - T\Delta S_H
$$

$$
\Delta E_H = E_{\text{Nb}(SxSe(1-x))2 + H} - E_{\text{Nb}(SxSe(1-x))2} - \frac{1}{2} E_{H_2}
$$

 $\Delta E_H$  represents energy of hydrogen adsorption. The equation considers the difference in hydrogen's zero-point energy and entropy between its adsorbed state and its gas phase.

### **Post HER Characterization of x = 0.5 (NbSSe):**





**Fig.** S11 TEM image of  $x = 0.5$  (NbSSe) after 9 h of chronoamperometry response. TEM image shows that the nanosheet morphology is retained after electro-catalysis.



**Fig. S12** XRD Pattern before and after electro-catalysis of NbSSe showing no phase change or formation of any other active species. The XRD pattern shows that the catalyst reamins structurally stable during the HER process.



**Fig. S13** After electro-catalysis FE-SEM image, corresponding elemental mapping and spectrum of  $x = 0.5$  (NbSSe) showing uniform distribution of elements i.e. Nb, Se and S. The spectrum clearly shows the detected elements are retained after running chronoamperometry response.

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